

Search Notes

Application/Control No.

10/683,947

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

MEEK ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
Update	Searched all previous cl/subs	10/14/2005	WSY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR